

Synthesis and luminescence properties of bluish-green emitting $\text{K}_2\text{MgSi}_3\text{O}_8:\text{Eu}^{2+}$ phosphor

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Abstract: Eu^{2+} -doped $\text{K}_2\text{MgSi}_3\text{O}_8$ phosphors were synthesized by conventional solid-state reaction method. The phase formation of as-prepared samples was characterized by X-ray powder diffraction. The luminescence properties were investigated by the photoluminescence excitation and emission spectra, decay curve and CIE coordinates. The phosphor showed bluish-green emission centered at 460 nm under the excitation of UV and near UV light with the wavelength range of 250–430 nm. Two Eu^{2+} emission centers existed in the $\text{K}_2\text{MgSi}_3\text{O}_8:\text{Eu}^{2+}$ phosphor according to the luminescence spectra and the decay curves. The critical quenching concentration of Eu^{2+} doping was determined to be 3.0 mol.% and the concentration quenching mechanism was dipole-dipole interactions between Eu^{2+} ions. These results suggested that $\text{K}_2\text{MgSi}_3\text{O}_8:\text{Eu}^{2+}$ was a potential bluish-green phosphor candidate for white UV-LED.

Keywords: $\text{K}_2\text{MgSi}_3\text{O}_8$; phosphors; luminescence; white UV-LED; rare earths

The absorption and emission spectra of Eu^{2+} -doped phosphors usually exhibit broad bands due to the allowed electric-dipole transitions between the $4f^7$ ground state and the $4f^65d^1$ excited state configuration^[1,2]. As a typical phosphor, Eu^{2+} -doped alkaline earth silicate phosphors can emit visible light when they absorb ultraviolet or blue (380–460 nm) light from LEDs chips. These phosphors have been investigated a lot due to the significant applications in white light-emitting diodes (W-LEDs). A lot of studies on Eu^{2+} -activated alkaline earth silicate phosphors have been published, such as $\text{Sr}_2\text{SiO}_4:\text{Eu}^{2+}$ ^[3], $\text{Ca}_3\text{Si}_2\text{O}_7:\text{Eu}^{2+}$ ^[4], $\text{SrCaSiO}_4:\text{Eu}^{2+}$ ^[5], $\text{CaAl}_2\text{Si}_2\text{O}_8:\text{Eu}^{2+}$ ^[6], $\text{BaCa}_2\text{MgSi}_2\text{O}_8:\text{Eu}^{2+}$ ^[7], $\text{Ba}_2\text{ZnSi}_2\text{O}_7:\text{Ce}^{3+}, \text{Eu}^{3+}, \text{Eu}^{2+}$ ^[8], and so on.

In recent years, Eu^{2+} -doped alkaline and alkaline-earth silicate phosphors have been paid more attention due to the lower calcining temperature and being easier to achieve electric charge balance compared with alkaline earth silicate phosphors for W-LEDs. Many systems have been reported. For example, $\text{Li}_2\text{SrSiO}_4:\text{Eu}^{2+}$ ^[9], $\text{K}_4\text{CaSi}_3\text{O}_9:\text{Eu}^{2+}$ ^[10], $\text{Na}_2\text{Ca}_3\text{Si}_6\text{O}_{16}:\text{Eu}^{2+}$ ^[11], $\text{Li}_2\text{Ca}_2\text{Si}_2\text{O}_7:\text{Eu}^{2+}$ ^[12], $\text{Li}_4\text{SrCa}(\text{SiO}_4)_2:\text{Eu}^{2+}$ ^[13], $\text{Na}_2\text{Ba}_6(\text{Si}_2\text{O}_7)(\text{SiO}_4)_2:\text{Eu}^{2+}$ ^[14], etc. This type of phosphors are one potential candidate in W-LEDs.

In this work, $\text{K}_2\text{MgSi}_3\text{O}_8:\text{Eu}^{2+}$ phosphors were first synthesized by conventional solid-state reaction. The structure of samples was measured by powder X-ray powder diffraction (XRD) measurements. The photolu-

minescence excitation and emission spectra, and the decay curves were investigated. The luminescence intensity measurements were performed as a function of Eu^{2+} concentration. The concentration quenching mechanism was discussed.

1 Experimental

1.1 Preparation of $\text{K}_2\text{MgSi}_3\text{O}_8:\text{Eu}^{2+}$ phosphors

$\text{K}_2\text{MgSi}_3\text{O}_8:x\text{Eu}^{2+}$ ($x=0.005\text{--}0.07$) phosphors were synthesized by conventional solid-state reaction method. The raw materials of K_2CO_3 (A.R.), $4\text{MgCO}_3\cdot\text{Mg}(\text{OH})_2\cdot 5\text{H}_2\text{O}$ (A.R.), SiO_2 (A.R.) and Eu_2O_3 (high purity, 99.99%) were ground together with stoichiometric amount in an agate mortar. First, the mixture was heated at 450 °C for 5 h. After a second homogenization in the mortar, the sample was heated at 750 °C for 10 h. After that, the sample was thoroughly mixed and heated again at 950 °C for 10 h in the flow atmosphere of 95% N_2 +5% H_2 .

1.2 Characterizations

The XRD patterns of samples were measured on a Rigaku D/Max-2000 diffractometer operating at 40 kV, 30 mA with Bragg-Brentano geometry by using $\text{Cu K}\alpha$ radiation ($\lambda=0.15418$ nm). A PerkinElmer LS-50B luminescence spectrometer and a Hitachi F-4500 fluorescence spectrophotometer were used to record the excita-

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tion and emission spectra. The luminescence decay curves were tested by the third harmonic (355 nm) of a pulsed Nd:YAG laser (Spectron Laser Sys. SL802G).

2 Results and discussion

2.1 XRD characterization

The samples were characterized by powder XRD measurements. The XRD patterns of the $K_2MgSi_3O_8:xEu^{2+}$ ($x=0.005-0.07$) are shown in Fig. 1. It can be observed that the XRD patterns of samples match the PDF2 standard card number 19-0973 ($K_2MgSi_3O_8$) well in the International Center for Diffraction Data (ICDD) database. No impurity lines were detected, and all the reflected lines could be well indexed to a $K_2MgSi_3O_8$ single phase.

2.2 Photoluminescent properties

The excitation and emission spectra of $K_2MgSi_3O_8:0.03Eu^{2+}$ at room temperature are presented in Fig. 2. The emission spectrum shows a broad emission band ranging from 370 to 580 nm with a maximum of 460 nm. It can be ascribed to $4f^65d^1 \rightarrow 4f^7$ electric transition of Eu^{2+} ions. The excitation spectra show the broad absorption bands covered from 250 to 430 nm. It can be attrib-

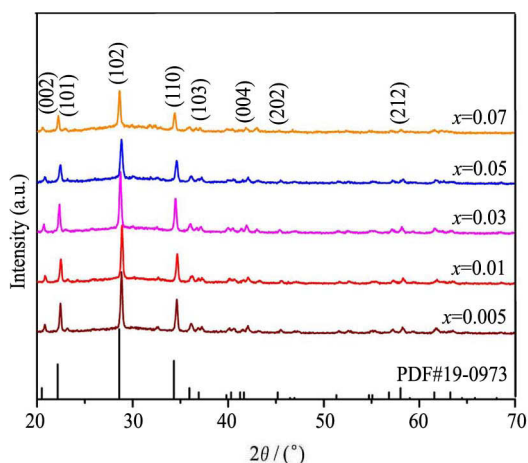


Fig. 1 XRD patterns of $K_2MgSi_3O_8:xEu^{2+}$ ($x=0.005, 0.01, 0.03, 0.05, 0.07$) and in comparison with standard card PDF#19-0973

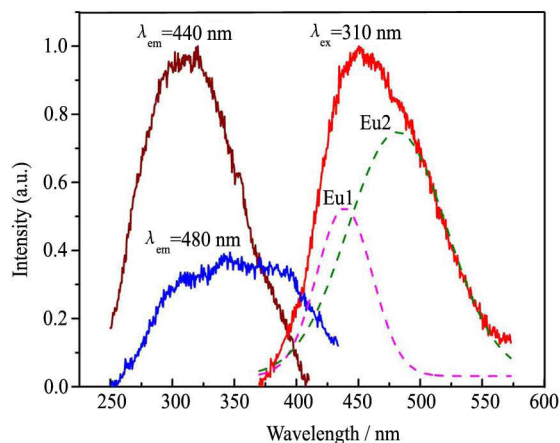


Fig. 2 Excitation and emission spectra of $K_2MgSi_3O_8:0.03Eu^{2+}$

uted to $4f-5d$ electric transition of Eu^{2+} ions. This means that the phosphor can match well with the emission light of UV-LED chips (360–400 nm)^[14].

The two excitation spectra ($\lambda_{em}=440$ nm and $\lambda_{em}=480$ nm, respectively) in Fig. 2 indicate that Eu^{2+} ions occupy more than one site in the lattice. The emission spectrum ($\lambda_{ex}=310$ nm) can be deconvoluted into at least two Gaussian components with peaks at 440 nm (referred to as Eu1) and 480 nm (referred to as Eu2). This indicates that two Eu^{2+} luminescence centers exist in $K_2MgSi_3O_8$ lattice.

Fig. 3 shows the luminescence decay curves of $K_2MgSi_3O_8:0.03Eu^{2+}$ phosphor under the excitation of 355 nm. It can be seen that the luminescence decay curves can be fitted by double exponential equation as follows:

$$I=I_1\exp[-t/\tau_1]+I_2\exp[-t/\tau_2] \quad (1)$$

where I_1 and I_2 are constant, τ_1 and τ_2 are luminescence lifetime. There are two kinds of decays in Fig. 3. One is slow decay and the luminescence lifetime is 1.75 μ s at the peak of 480 nm, the other is fast decay and the luminescence lifetime is 1.44 μ s at the peak of 440 nm. In view of the different luminescence lifetimes in Fig. 3 (1.44 μ s for 440 nm and 1.75 μ s for 480 nm), two different emission centers are also identified to exist in the lattice of $K_2MgSi_3O_8$.

The emission spectra of $K_2MgSi_3O_8:xEu^{2+}$ phosphors with Eu^{2+} content are presented in Fig. 4. The emission spectra show that the emission intensity varies as the content of Eu^{2+} increased. As shown in the upper inset of Fig. 4, the emission intensity increases with increasing Eu^{2+} content up to a maximum value at $x=0.03$. Then the emission intensity decreases when the Eu^{2+} content further increases beyond $x=0.03$ because of the concentration quenching effect. Moreover, it can be observed that the peak center shifts to long wavelength with Eu^{2+} content increasing. This is caused by the $K_2MgSi_3O_8$ lattice distortion originated by bigger radius of Eu^{2+} ions.

As discussed above, there are two Eu^{2+} luminescence centers in $K_2MgSi_3O_8$ lattice. Fig. 5 shows the relation-

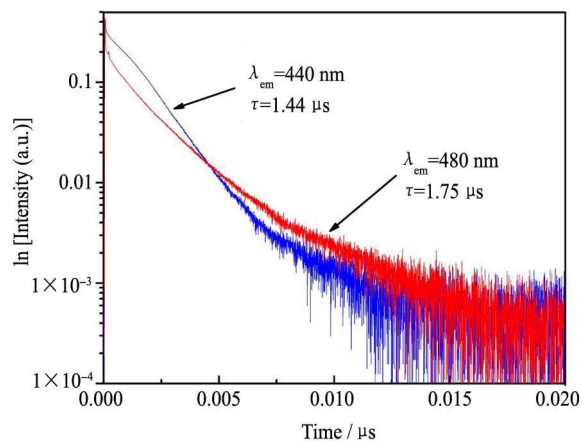


Fig. 3 Decay curves of emission bands at 440 and 480 nm in $K_2MgSi_3O_8:0.03Eu^{2+}$ under the excitation of 355 nm

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